

**Search Notes**

Application/Control No.

10/501,323

Examiner

John Kreck

Applicant(s)/Patent under  
Reexamination

FUJII ET AL.

Art Unit

3673

**SEARCHED**

Class	Subclass	Date	Examiner
405	128.75		
	263		
	264	7/27/2005	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search attached	7/27/2005	